

<b>FORM PTO-1449/A and B (Modified)</b>  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>		APPLICATION NO.: Unassigned	ATTY. DOCKET NO.: <sup>10/757682</sup> S1022.81108US00
		FILING DATE: Herewith	CONFIRMATION NO.: Unassigned
		APPLICANT: Hilal EZZEDDINE et al.	
		GROUP ART UNIT: Unassigned	EXAMINER: Unassigned
Sheet	1	of	1

#### U.S. PATENT DOCUMENTS

Examiner's Initials	Cite No.	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication or of issue of Cited Document MM-DD-YYYY
		Number	Kind Code		
DT	*	4,937,541		Allen F. Podell et al.	06/26/90
DT	*	5,629,654		Eric A. Frick	05/13/97

#### FOREIGN PATENT DOCUMENTS

Examiner's Initials	Cite No.	Foreign Patent Document			Name of Patentee or Applicant of Cited Document (not necessary)	Date of Publication of Cited Document MM-DD-YYYY	Translation (Y/N)
		Office/Country	Number	Kind Code			

#### OTHER ART — NON PATENT LITERATURE DOCUMENTS

Examiner's Initials	Cite No	Include name of the author (in CAPITAL LETTERS) title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, relevant page(s), volume-issue number(s), publisher, city and/or country where published.	Translation (Y/N)
DT		French Search Report from French Patent Application 02/15477, filed December 6, 2002	
DT		Ojha S. et al. "Reduced Size RF Coupler Design For Specialized Load Requirements" Circuits and Systems, 1997. Proceedings Of The 40 <sup>th</sup> Midwest Symposium on Sacramento, CA, USA 3-6 Aug. 1997, New York, NY USA, IEEE, US, August 3, 1997, pages 595-598	
DT		Patent Abstracts of Japan, vol. 005, no. 125 (E-069), August 12, 1981 & JP 56 062402 A (Fujitsu Ltd.) May 28, 1981	
DT		Patent Abstracts of Japan, vol. 018, no. 022 (E-1490), January 13, 1994 & JP 05 259717 A (NEC Corp.), October 8, 1993	
DT		Cne J-L et al. "A High-Directivity Microstrip Directional Coupler With Feedback Compensation" 2002 IEEE MTT-S International Microwave Symposium Digest. (IMS 2002). Seattle, WA June 2-7, 2002, IEEE MTT-S International Microwave Symposium, New York, NY: IEEE, US, vol. 1 of 3, June 2, 2002, pages 101-104	
DT		Patent Abstracts of Japan, vol. 2003, no. 02, February 5, 2003 & JP 2002 299922 A (Kyocera Corp.), October 11, 2002	

EXAMINER <i>Dean Tokuda</i>	DATE CONSIDERED <i>2/23/05</i>
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#EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.